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## Gelation of uranyl ions and gel-derived uranium oxide nanoparticles for gas sensing†

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We developed a sol–gel method to synthesize uranium oxide nanoparticles with a clean surface and mixed valences of uranium at the surface. Uranyl gel was formed in ethylene glycol without incorporating any organic gelator and was readily converted to uranium dioxide nanoparticles with uniform size *via* microwave treatment. The as-prepared uranyl gel showed a high storage modulus of 0.48 kPa. The formation of the gel skeleton benefits from interlinkage of uranyl ions, which was revealed by UV-Vis spectroscopy and X-ray absorption. The U=O<sub>ax</sub> bond was elongated by 0.1 Å and the U–O<sub>eq</sub> bond was shortened by 0.25 Å by the gelation. The gel showed thixotropic and self-healing properties owing to the soft connection in the gel skeleton and photo-response attributed to the photo-reduction reaction between uranyl ions and matrix solvent. With the great inclusion properties, the uranyl gel was decomposed by microwave treatment into uranium dioxide nanoparticles with a size of ~4 nm. The resultant UO<sub>2</sub> nanoparticles were easily oxidized in air, and thus presented an n-type semiconductor behaviour and sensitivity to both oxidative and reductive gases such as NO<sub>2</sub>, EtOH, CO, and NH<sub>3</sub>.

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### Introduction

Uranium with abundant 5f electrons exhibits splendid chemical properties such as variable valence states and multiple oxide phases. The thermodynamically stable phases of the binary oxides are UO<sub>2</sub>, U<sub>4</sub>O<sub>9</sub>, U<sub>3</sub>O<sub>8</sub> and UO<sub>3</sub>.<sup>1</sup> Many other metastable oxides also exist. Uranium oxide with flexible oxidation states has widespread applications in catalysis.<sup>2–8</sup> For example, U<sub>3</sub>O<sub>8</sub> is efficient for destruction of a range of volatile chloro-organic compounds under mild conditions.<sup>2,9</sup> U<sub>3</sub>O<sub>8</sub>/ZrO<sub>2</sub> is a remarkable heterogeneous catalyst for the oxidation of HCl to Cl<sub>2</sub>.<sup>6</sup> However, the application of uranium oxide in other fields is still relatively rare.

Transition metal oxide semiconductors have been widely studied as gas sensing materials and their n/p-type nature affects the behaviour in gas detection.<sup>10–15</sup> Uranium oxides with variable valence states can easily produce defects. As a result, the surface chemistry of uranium oxides is more sensitive to the changes of the peripheral environment. The oxygen ions adsorbed on defects can undergo electron transfer with the gas molecules, thereby affecting the conductivity of the oxides. Meanwhile, the semiconducting properties of uranium oxides

are closely related to their stoichiometry.<sup>16–18</sup> UO<sub>2</sub> with a fluorite structure is able to accommodate up to 10% additional oxygen in its lattice without any change of the structure, acting as a p-type semiconductor.<sup>19</sup> Further increase of the O/U ratio results in a change of structure to U<sub>3</sub>O<sub>8</sub>, which is an n-type semiconductor.<sup>1</sup> Thus, the versatile properties of uranium oxides endow them with great potential in gas sensing.

Gas sensing is based on the adsorption and/or reaction occurring at the surface, so it is meaningful to control the size of the uranium oxide in the nanometer range to obtain a high specific surface area. Synthesis of uranium oxide nanoparticles was recently realized by liquid-phase pyrolysis in an oleic acid/oleylamine system and hydrothermal/solvothermal methods.<sup>4,12,20–26</sup> The hydrothermal/solvothermal treatments show poor control over the size and morphology of the resultant nanoparticles. The liquid-phase pyrolysis process exhibits good controllability on the size and morphology of the nanoparticles, but the organic capping reagents adsorbed on their surface hinder the sensing performance.

The sol–gel method has been a conventional pathway to prepare microspheres of uranium dioxide in the nuclear industry. In this process, hexamethylenetetramine, urea and some polymers are used to promote the formation of uranyl gels.<sup>27,28</sup> Then the uranium dioxide microspheres are obtained by further annealing the gel. It is of interest to develop a sol–gel process with a simple recipe for the synthesis of uranium oxide nanoparticles.

Herein, we established a gel-based preparation for uranium nanoparticles and fabricated uranium-based gas sensing devices. The gel formed immediately after mixing the uranyl ethylene

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glycol (EG) solution with ammonia solution. Then the urania nanoparticles were obtained by microwave-assisted decomposition of the gel. The urania nanoparticles have a uniform size of  $\sim 4$  nm and present a  $\text{U}_3\text{O}_8$  surface layer, which leads to inversed semiconductive properties from p-type to n-type. The unique surface properties endow the nanoparticles with sensitivity towards both reductive and oxidative gases.

## Experimental

### Materials and methods

Ethylene glycol (EG) (A.R., Sinopharm Chemical Reagent), ammonia water (30%) (A.R., Beijing TongGuang Fine Chemical), and  $\text{U}_3\text{O}_8$  (A.R., China National Nuclear) were used. All chemicals were used as received.

### Preparation of uranyl nitrate hexahydrate (UNH)

2.5 g (3 mmol)  $\text{U}_3\text{O}_8$  and 2 mL  $\text{HNO}_3$  were mixed in an evaporating basin until no reddish-brown gas evolution was observed anymore. The uranyl nitrate solution was heated and after the solvent had evaporated, a yellow crystalline raw-product was obtained. Then the raw product was purified *via* recrystallization from water three times at room temperature.

### General procedure for the preparation of the uranyl-EG (ethylene glycol) gel

1.3 mL ethylene glycol and 0.2 mL (0.1 M in ethylene glycol) uranyl nitrate solution were mixed with a defined amount of ammonia (5–100  $\mu\text{L}$ ). The resultant reaction mixture was allowed to stand. A transparent yellow gel formed within seconds.

### Preparation of uranium dioxide nanoparticles

The crystalline uranium dioxide nanoparticles were obtained by reducing the uranyl EG gel under microwave irradiation. Typically, 7 mL of the uranyl EG gel were transferred to a pressure-resistant microwave vessel and maintained at 200 °C and 12.0 bar for 30 min under irradiation in dynamic power mode at 50 W. The product was centrifuged and washed with deionized water and ethanol three times followed by drying in a vacuum at 60 °C. The microwave reaction was achieved using a commercialized Discover® SP Sequential Microwave Synthesis System.

### Characterization

The phase composition was determined using a Stoe-Stadi MP X-ray diffractometer operating in transmission mode using  $\text{Mo-K}_{\alpha 1}$  ( $\lambda = 0.7093 \text{ \AA}$ ) radiation. The morphologies of nanoparticles were investigated with a scanning electron microscope (SEM, Hitachi S-4800) and a transmission electron microscope (TEM, Zeiss LEO 912, 120 kV). The X-ray photoelectron spectra (XPS) were recorded with a Surface Science Instruments ESCA M-Probe using monochromatic Al- $\text{K}_{\alpha}$  radiation ( $h\nu = 1486.6 \text{ eV}$ ). The spectra were fitted and analysed with CasaXPS software. The X-ray absorption fine structure (XAFS) spectra at the uranium  $\text{L}_3$ -edge ( $E_0 = 17\,166 \text{ eV}$ ) were collected at the BL14W1

beamline of the Shanghai Synchrotron Radiation Facility (SSRF). The energy was calibrated according to the absorption edge of the Zr foil at the K-edge (17 997 eV). Rheological experiments were performed on a rheometer (MCR301, Anton Paar); frequency sweep tests were carried out at a fixed strain of 0.5%; amplitude sweep tests were performed at a fixed frequency of 1 Hz. The UV-Vis measurements were performed on a PerkinElmer Lambda 750 spectrophotometer. The photoluminescence (PL) emission spectra were recorded with a Hitachi F-7000 luminescence spectrometer with an excitation wavelength of 375 nm. A light response test was performed by illumination under Xe light of 150 W.

### Gas sensing measurements

The gas sensing properties of uranium dioxide nanoparticles towards different gases ( $\text{NO}_2$ , EtOH,  $\text{NH}_3$  and CO) were examined using a customized gas sensing system operating at 200 °C, interfaced to a Keithley 2400 source meter and controlled by Lab View software for resistivity measurements.

### Mott-Schottky measurements

All electrochemical measurements were performed using a one-compartment, 3-electrode cell with the  $\text{UO}_2/\text{FTO}$  sample as the working electrode, platinum (Pt) wire as the counter electrode and a saturated calomel electrode (SCE) as the reference electrode. 0.1 M  $\text{Na}_2\text{SO}_4$  was used as the electrolyte. The Keithley 2400 source meter applied the potential and an Agilent E4980A LCR meter recorded the capacitance controlled by the Lab View software.

### Safety instruction

The uranium used in this work has activity less than 0.2 kBq  $\text{g}^{-1}$ . However, prolonged exposure to radioactive material (by oral or nasal routes) may have adverse health effects and must be avoided.

## Results and discussion

Fig. 1a presents a photograph of the uranyl gel in an inverted glass tube, which exhibits a transparent yellow jelly-like appearance. The mechanical viscoelastic properties of the uranyl gel were investigated by rheological studies (strain and frequency sweeps). As shown in Fig. 1c and d, the measurements at a constant strain of 0.5% revealed that the storage modulus ( $G'$ ) is 0.29 kPa larger than the loss modulus ( $G''$ ) and both of them ( $G'$  and  $G''$ ) are independent of the angular frequency ( $\omega$ ). The amplitude of the storage modulus amounts to 0.48 kPa in the linear regime, which is at the same magnitude range as reported for Eu(III) metallo gels (0.41 kPa).<sup>29</sup> Furthermore, we found that the uranyl-EG gel showed ‘thixotropy’ (Fig. S1†), which is a time-dependent shear thinning property. This phenomenon indicates that the gel network was not rigid and easy to recover.

The gelation abilities of uranyl nitrate were examined by varying the  $\text{NH}_4\text{OH}$  concentration, additional amount of water, and uranyl nitrate concentration (Table 1). The critical gelation



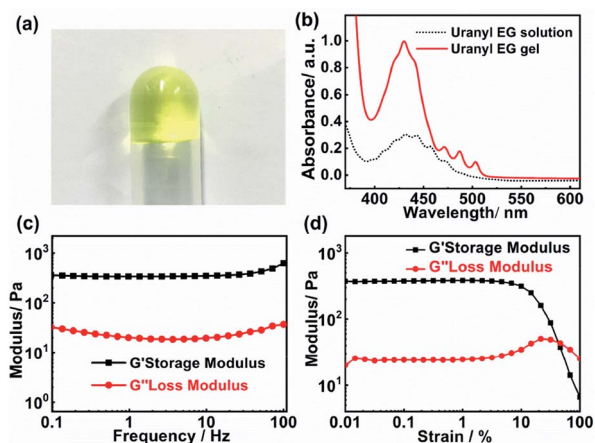
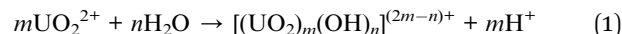


Fig. 1 (a) The photograph of the uranyl EG gel. (b) The UV-Vis absorption spectra of the uranyl EG gel and the uranyl EG solution. (c) and (d) The rheology properties of uranyl gel. (c) Dependence of the dynamic storage modulus ( $G'$ ) and loss modulus ( $G''$ ) on the frequency at a constant strain of 0.5%. (d) Dependence of the dynamic storage modulus ( $G'$ ) and loss modulus ( $G''$ ) on the strain at a constant frequency of 1 Hz.

concentration (CGC) was evaluated to be 3.3 mM and 0.15 wt% of uranyl nitrate, which was at a low concentration level when compared to other metalloids.<sup>30–32</sup> In addition, the ammonia concentration played a critical role in the gelation process. When the concentration of ammonium hydroxide was less than 0.3 vol%, a stable solution was obtained. An excess of ammonium hydroxide (33 vol%) or water (3.0 vol%) directly led to precipitation of uranyl hydroxide which was due to fierce hydrolysis of uranyl ions under the alkaline conditions. Therefore, the absorbance was enhanced in the range of 400–500 nm after gelation, which was due to the increasing oligomerisation of uranyl ions (Fig. 1b). It was reported that the molar absorption of  $(\text{UO}_2)_3(\text{OH})^{5+}$  species ( $474 \pm 7 \text{ mol}^{-1} \text{ cm}^{-1}$  at 429.0 nm) is 48 times that of free  $\text{UO}_2^{2+}$  ( $9.7 \pm 2 \text{ mol}^{-1} \text{ cm}^{-1}$  at 413.8 nm).<sup>33,34</sup>

From the results shown above, we inferred that both the ammonia and water concentrations influenced the degree of hydrolysis of uranyl ions and thus the gelation properties. It is well known that the degree of hydrolysis varies with pH of the solution. When increasing the pH, oxo/hydroxo bridges can be created between the uranyl centered polyhedra, leading to the formation of higher nuclearities (e.g.,  $[(\text{UO}_2)_2(\text{OH})_2]^{2+}$ ,

$[(\text{UO}_2)_3(\text{OH})_5]^+$  and  $[(\text{UO}_2)_4(\text{OH})_7]^+$ ).<sup>35,36</sup> This fact is confirmed by detailed studies on uranyl ion hydrolysis, following eqn (1).<sup>37</sup>



Owing to the very low concentration (3.3–13.2 mmol L<sup>-1</sup>) of uranyl ions in the gel and the precursor solution, the vibration signal of the U=O bond was submerged in the signals of the solvent and hard to distinguish. As shown in Fig. S2(a),† the absorption in the IR spectra were mainly contributed by the solvent, ethylene glycol (EG). In the spectrum of EG, the peak at 1657 cm<sup>-1</sup> (bending vibration mode of H–O–H) implied the existence of residual water. However, in the spectra of uranyl-EG solution and uranyl-EG-gel, this band almost disappeared. It was likely caused by the water consumption from the hydrolysis of uranyl ions, according to eqn (1). For more discussion, please see the ESI.†

The coordination environment around uranium atoms in the uranyl EG gel and uranyl EG solution was further identified via XAFS analysis at the uranium L<sub>3</sub>-edge. The signal at 17 178 eV was detected in both spectra and was assigned to uranium in the +6 oxidation state, indicating that the oxidation state did not change during gelation.<sup>38</sup> Two prominent resonance features are visible in the XANES spectra of uranyl-containing compounds (A and B, Fig. 2a). Feature A (~17 190 eV) is attributable to the short axial U–O bonds in the dioxoanyl species, while feature B (~17 210–17 215 eV) is attributable to the longer U–O equatorial bonds.<sup>39,40</sup> Upon gelation, feature A shifts to a lower photon energy (17 194 to 17 191 eV), while feature B shifts to higher energy (17 211 to 17 215 eV). Energy shifts of these resonance features were reported to be inversely proportional to the changes in the corresponding U–O bond lengths.<sup>41</sup> The extended X-ray absorption fine structure spectroscopy measurement in *R* space, which allows determination of the bond length of the central uranium atom to the coordinating ligand atoms, is depicted in Fig. 2b. The first peak is assigned to the U=O bond (axial position) and amounts to 1.64 Å for the uranyl EG solution and to 1.73 Å for the uranyl EG gel. The second peak was assigned to the U–O bond (equatorial plane), and amounts to 2.37 Å and 2.12 Å for the uranyl EG solution and the uranyl EG gel, respectively.<sup>42</sup> The bond length data were all within the range of the axial U=O bond (1.77 Å) and U–O bond (2.42 Å) of uranium nitrate reported in the literature with the consideration of phase correction.<sup>43</sup> These results illustrated that both a longer U=O bond and a shorter

Table 1 Gelation behaviour of uranyl nitrate under different conditions<sup>a</sup>

| NH <sub>4</sub> OH conc. (vol%) |   | Additional H <sub>2</sub> O (vol%) |   | UO <sub>2</sub> (NO <sub>3</sub> ) <sub>2</sub> ·6H <sub>2</sub> O conc. (mM) |   |
|---------------------------------|---|------------------------------------|---|---|---|
| 0.3                             | S | 0                                  | G | 3.3   | S |
| 1.3                             | G | 0.1                                | G | 6.6   | G |
| 2.0                             | G | 0.3                                | G | 9.9   | G |
| 4.6                             | G | 1.6                                | G | 13.2  | G |
| 33                              | P | 3.0                                | P | 16.5  | P |

<sup>a</sup> S, G and P denote solution, gelation, and precipitation, respectively.



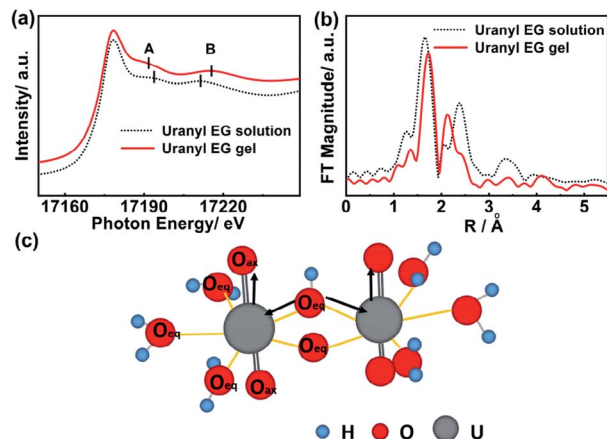


Fig. 2 (a) XANES ( $L_{3}$ -edge of uranium) and (b) EXAFS spectra of uranyl EG solution and uranyl EG gel; FT peak positions are not corrected for phase shifts. A and B show features related to the axial and equatorial U–O bonds, respectively. (c) The scheme of the elongation of the U–O<sub>ax</sub> bond length and the shortening of the U–O<sub>eq</sub> bond length of the hydroxo species in the gel phase.

U–O bond are present in the gel phase, which indicates a stronger coordination tendency of the ligands in the equatorial plane as compared to the uranyl EG solution (Fig. 2c). Fierce hydrolysis of the uranyl ions in the gel occurred, which resulted in more bridge O atoms and shorted the equatorial U–O bond.

Besides the hydrolysis effect, the uranyl ion exhibited interactions with the solvent ethylene glycol. Aliphatic alcohols are moderately strong quenchers of the excited state of the uranyl ion.<sup>44–46</sup> The quenching occurred in a kinetic encounter between [ $*\text{UO}_2$ ]<sup>2+</sup> and alcohol and was accompanied by the reduction of uranium(vi) and oxidation of the organic species to generate aldehydes. Fig. S3† shows the luminescence quenching of the uranyl ion by EG. By taking advantage of the quenching effect, the gel shows a photo-response. The uranyl EG gel was exposed to light illumination for different time periods (5 min and 10 min) as shown in Fig. 3b and c. Interestingly, the gel showed a reversible photo-response. After 5 min of illumination, the gel turned brown, but remained in the gel state. After 10 min, the color was darker and the gel converted to a solution, which was caused by a heating effect from the light, confirmed through a heating experiment. Upon removing the light, the gel was gradually recovered within two days, thus demonstrating

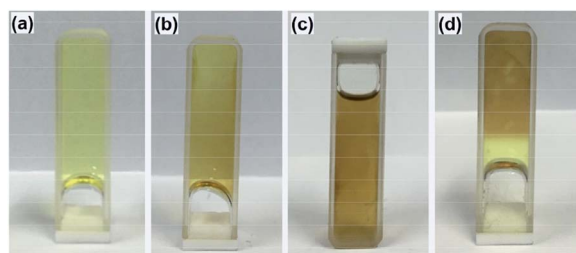


Fig. 3 Photograph of the uranyl EG gel (a) before and (b) after being exposed to light illumination for 5 min and (c) 10 min, and (d) recovery of the uranyl EG gel after two days without light illumination.

a reversible photo-response as a result of oxygen permeation into the cuvette.

The photo-reduced product was collected by centrifugation and the gel skeleton information was obtained *via* TEM. It shows that the skeleton retained a porous network (Fig. S5†). The pore size is approximately 15 nm. Electron diffraction shows polycrystalline diffraction rings representing interplanar distances of 0.315 nm, 0.275 nm and 0.191 nm, which correspond to the (111), (200), and (220) crystal planes of  $\text{UO}_2$ , respectively. This indicates that U(vi) was reduced *in situ* to U(IV) during the photoreaction of the gel.

With the great inclusion properties, the uranyl EG was used as precursor for the synthesis of uranium oxide nanoparticles. Fig. 4a shows the TEM image of nanoparticles obtained from the microwave decomposition. The XRD pattern (Fig. 4c) was unambiguously assigned to the cubic phase  $\text{UO}_2$ . The peaks at  $2\theta = 13.7^\circ$ ,  $15.6^\circ$ ,  $21.8^\circ$  and  $25.6^\circ$  were indexed to the (111), (200), (220) and (311) planes, respectively. Peak broadening resulted from the nano-scale size of the particles. The size distribution of  $\text{UO}_2$  is shown in Fig. S4† based on measurements of 109 particles in TEM images. The mean size is  $3.4 \pm 0.6$  nm, which is in accordance with the result from the Debye-Scherrer equation calculation ( $\sim 4$  nm).<sup>47</sup>

The XRD pattern coincided with the results from the electron diffraction pattern (Fig. 4b). The distances of 0.318 nm, 0.276 nm, 0.194 nm and 0.169 nm were attributed to the (111), (200), (220) and (311) planes, respectively. The XPS survey spectrum (Fig. 4d) revealed that the sample solely contained U, O, and C elements with no coexisting impurities. The two peaks located at 392 eV and 381 eV were assigned to the binding energy of U  $4f_{5/2}$  and U  $4f_{7/2}$ , respectively.<sup>48</sup>

$\text{UO}_2$  is a semiconductor, which can accommodate an excess or deficiency of oxygen without changing its crystal phase. This pronounced valence variation gives rise to the sensitivity of electrical conductivity towards oxidizing and reducing gases.<sup>49</sup> In our synthesis procedures, besides the uranium source, only water, ethylene glycol, and ammonia were introduced into the

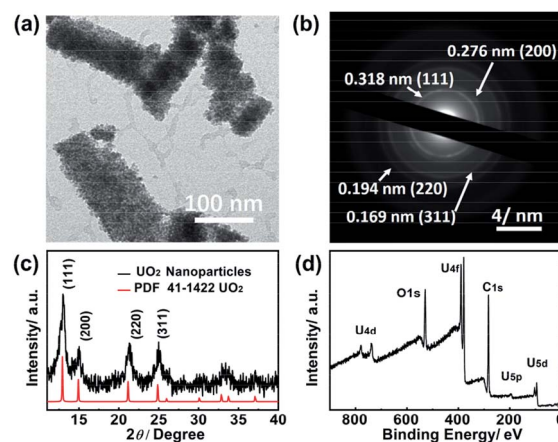


Fig. 4 (a) TEM image, (b) electron diffraction pattern, (c) powder XRD pattern and (d) XPS survey spectrum of uranium dioxide nanoparticles derived from the microwave decomposition of the uranyl EG gel.



system. Therefore, the urania nanoparticles obtained present a clean surface. Indeed, nanoparticles with a clean surface are highly desired in gas sensing. Herein, gas sensing devices were prepared on ceramic substrates with four evaporated Pt electrodes used for the input of the heating power, as well as to monitor the resistance of the sensing materials (Fig. S6†). The dynamic sensing behavior of the uranium dioxide sensor upon exposure to different gases was investigated at 200 °C (Fig. 5). In the case of the oxidizing gas NO<sub>2</sub>, the resistance of the UO<sub>2</sub> sensor increased (20 ppm, ΔR = 7.8 kΩ, sensitivity ~ 36%). The order of magnitude of sensitivity is comparable to the previously reported ones using other oxides: 10–40% at 1–5 ppm NO<sub>2</sub> for a SnO<sub>2</sub>–ZnO core–shell nanofiber sensor,<sup>50</sup> 35% at 500 ppb NO<sub>2</sub> for In<sub>2</sub>O<sub>3</sub> nanowires, and 30–200% at 1 ppm NO<sub>2</sub> for WO<sub>3</sub> nanorods.<sup>51,52</sup>

We also applied the nanoparticles in sensing reductive gases. A resistance decrease of the UO<sub>2</sub> sensor was observed in the case of reducing gases such as ethanol (1000 ppm, ΔR = –0.6 kΩ, sensitivity ~ 3%), CO (1000 ppm, ΔR = –0.3 kΩ, sensitivity ~ 1.4%), and NH<sub>3</sub> (500 ppm, ΔR = –30 kΩ, sensitivity ~ 6.8%). Fig. 5e and f show the CO gas sensing response, expressed as a resistance variation, for 200, 400, 600, 800, and 1000 ppm CO. We observed an increase in resistance with an increase in gas concentration. Generally, the ionosorption model was applied to explain the mechanism of the semiconductor gas sensing material.<sup>53</sup> In this model, the surface-adsorbed oxygen ions are considered to be the determining factor in the chemiresistive

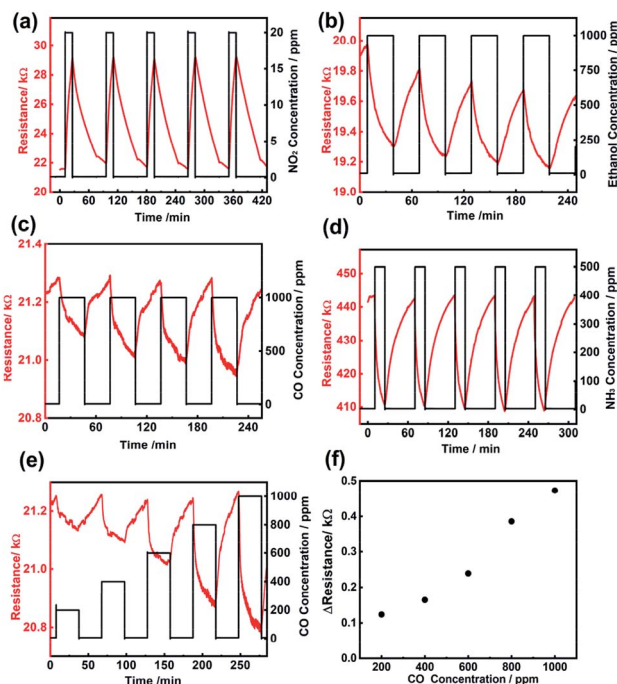


Fig. 5 Dynamic response–recovery curves of the gas sensor based on uranium dioxide nanoparticles towards (a) 20 ppm NO<sub>2</sub>; (b) 1000 ppm EtOH; (c) 1000 ppm CO; (d) 500 ppm NH<sub>3</sub>; and (e) varying CO concentration; (f) CO sensing response as a function of gas concentration. For measuring the NO<sub>2</sub> response, a 200 sccm N<sub>2</sub> flush was used for 1 h to recover the baseline.

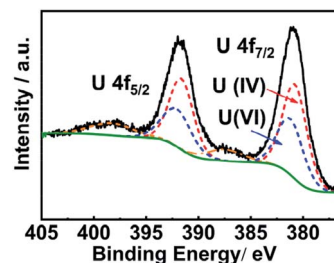


Fig. 6 High resolution U 4f XPS spectrum of uranium dioxide nanoparticles derived from the microwave decomposition of the uranyl EG gel. The spectrum was fitted with peaks of U(IV) and U(VI) (dashed lines).

behavior. For n-type semiconductors, oxygen ions (O<sub>2</sub><sup>–</sup><sub>ads</sub>, O<sup>–</sup><sub>ads</sub>, and O<sup>2–</sup><sub>ads</sub>) are formed *via* an uptake of electrons from the conduction band (CB). When reducing gases such as CO react with these oxygen ions, electrons are released back to the conduction band, thus increasing the electrical conductivity of the semiconductor. If oxidizing gases are present, more electrons are taken from the conduction band, which results in a decrease in conductivity. As the resistance decreased upon exposure to reducing gas, the as-prepared UO<sub>2</sub> nanoparticle sensor exhibits an n-type semiconducting behavior.

The semiconducting properties of uranium oxides have been reported to be influenced by the valence state of uranium. In general, uranium dioxide is regarded to be a p-type semiconductor due to the extra oxygen doping with stoichiometric form UO<sub>2+x</sub> (0 < x < 0.22).<sup>54,55</sup> In contrast, the oxygen deficient form (UO<sub>2–x</sub>) is an n-type semiconductor, obtained by Ar<sup>+</sup> sputtering or in a strong reducing environment.<sup>1,56,57</sup> However, the gel-derived UO<sub>2</sub> nanoparticles are not consistent with any of the above situations.

High resolution XPS spectroscopy was performed to investigate the surface oxidation state of UO<sub>2</sub> nanoparticles (Fig. 6). The 4f<sub>5/2</sub> peak at 391.62 eV and the 4f<sub>7/2</sub> signal at 380.77 eV were ascribed to U(IV) and the 4f<sub>5/2</sub> signal at 392.07 eV and 4f<sub>7/2</sub> peak at 381.22 eV originated from U(VI). The ratio of U(IV)/(VI) was 3 : 2. As the mixed-valence oxide U<sub>3</sub>O<sub>8</sub> is the most stable phase and exhibits n-type semiconducting behavior, we proposed that a thin layer of U<sub>3</sub>O<sub>8</sub> formed on the surface of the nanoparticles. The U 4f full-width at half maximum (FWHM) was 2.7 eV, obviously different from those of the pure UO<sub>2</sub> (1.90 to 1.95 eV), also indicating that UO<sub>2</sub> was converted to U<sub>3</sub>O<sub>8</sub> (FWHM 2.75

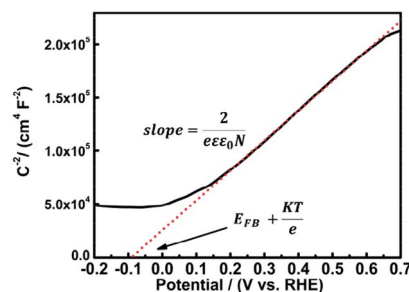


Fig. 7 Mott–Schottky plot for gel-derived UO<sub>2</sub> nanoparticles.



eV).<sup>58</sup> Since the size of uranium dioxide nanoparticles ( $\sim 4$  nm) was in the range of the penetration depth of XPS for inorganic materials ( $\sim 5$  nm), the composition of nanoparticles could be regarded as mixed oxides of  $\text{UO}_2/\text{U}_3\text{O}_8$  in a 2 : 1 ratio.

To verify the semi-conductor type of the as-prepared  $\text{UO}_2/\text{U}_3\text{O}_8$  nanoparticles, Mott–Schottky measurements were performed (Fig. 7). The sample was prepared *via* drop coating a dispersion of  $\text{UO}_2/\text{U}_3\text{O}_8$  nanoparticles in ethanol onto a FTO substrate. The electrode area was determined by optical microscopy (Fig. S7 and S8†).

$$\frac{1}{C^2} = \frac{2}{e\epsilon\epsilon_0 N} \left( E - E_{\text{FB}} - \frac{KT}{e} \right)$$

where  $C$  = capacitance of the space charge region,  $\epsilon$  = dielectric constant of the semiconductor,  $\epsilon_0$  = permittivity of free space,  $N$  = donor density (electron donor concentration for an n-type semiconductor or hole acceptor concentration for a p-type semiconductor),  $E$  = applied potential, and  $E_{\text{FB}}$  = flatband potential.

According to the Mott–Schottky equation,<sup>59,60</sup> the flat-band potential of  $\text{UO}_2/\text{U}_3\text{O}_8$  was  $-0.115$  V *versus* RHE in 0.1 M  $\text{Na}_2\text{SO}_4$ . To determine the donor density, a dielectric constant of 22 was applied for this system,<sup>61</sup> and  $N = 2.29 \times 10^{22} \text{ cm}^{-3}$  was determined from the slope of the Mott–Schottky plot. For n-type semiconductors the slope of the Mott–Schottky plot is positive, while for p-type semiconductors the slope is negative. Thus, the gel-derived  $\text{UO}_2/\text{U}_3\text{O}_8$  material is an n-type semiconductor, which coincides with the results from the gas sensing measurements.

The as-prepared crystalline  $\text{UO}_2$  nanoparticles are easily oxidized in air to form  $\text{U}_3\text{O}_8$  at the surface. Because of the small size and high surface area of the nanoparticles, the conduction behavior of the n-type  $\text{U}_3\text{O}_8$  layer dominated over the conduction behavior of the p-type  $\text{UO}_2$ . This phenomenon has been reported before for  $\text{CuO}$  nanowires coated with  $\text{SnO}_2$  nanoparticles and  $\text{Cr}_2\text{O}_3$  nanoparticle-coated  $\text{ZnO}$  nanowire systems.<sup>62,63</sup> When the  $\text{U}_3\text{O}_8$  surface is exposed to reducing gases, the conductivity increases as electrons are released to the conduction band from the oxygen ions (Fig. 8).

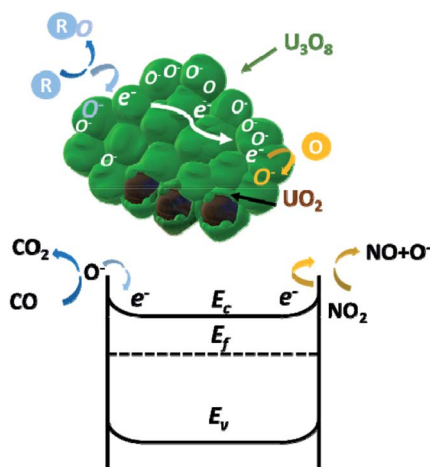


Fig. 8 Gas sensing mechanism of  $\text{UO}_2/\text{U}_3\text{O}_8$  nanoparticles when exposed to oxidizing and reducing gases.

## Conclusions

We prepared a uranyl organic gel in ethylene glycol without the addition of gelators. The gel exhibited both ‘thixotropy’ properties and light response behaviour. The unique coordination properties of the uranyl ion played the main role in gel skeleton formation. As the uranyl ion exhibited a strong interaction with the solvent in the gel network, it was deemed to be a good precursor for nanoparticle synthesis. The gel-derived uranium oxide nanoparticles were synthesized *via* microwave-assisted decomposition. The clean surface of the resultant nanoparticles is beneficial for applications in gas sensing. These nanoparticles showed n-type semiconducting behavior because the  $\text{UO}_2$  nanoparticles were partially oxidized to  $\text{U}_3\text{O}_8$ . The unique property of mixed valences of uranium at the surface results in a dual sensitivity to both reductive and oxidative gases, which may have application potential.

## Conflicts of interest

There are no conflicts of interest to declare.

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## Notes and references

- H. Idriss, *Surf. Sci. Rep.*, 2010, **65**, 67–109.
- J. H. Graham, S. H. Catherine, D. H. Ian and H. T. Stuart, *Nature*, 1996, **384**, 341–343.
- S. D. Pollington, A. F. Lee, T. L. Overton, P. J. Sears, P. B. Wells, S. E. Hawley, I. D. Hudson, D. F. Lee and V. Ruddock, *Chem. Commun.*, 1999, 725–726.
- Q. Wang, G.-D. Li, S. Xu, J.-X. Li and J.-S. Chen, *J. Mater. Chem.*, 2008, **18**, 1146.
- Z. R. Ismagilov, S. V. Kuntsevich, N. V. Shikina, V. V. Kuznetsov, M. A. Kerzhentsev, V. A. Ushakov, V. A. Rogov, A. I. Boronin and V. I. Zaikovskiy, *Catal. Today*, 2010, **157**, 217–222.
- A. P. Amrute, F. Krumeich, C. Mondelli and J. Pérez-Ramírez, *Chem. Sci.*, 2013, **4**, 2209.
- Z. R. Ismagilov and S. V. Lazareva, *Catal. Rev.*, 2013, **55**, 135–209.
- M. Gliński, G. Zalewski, E. Burno and A. Jerzak, *Appl. Catal., A*, 2014, **470**, 278–284.
- S. H. Taylor, C. S. Heneghana, G. J. Hutchings and I. D. Hudson, *Catal. Today*, 2000, **59**, 249–259.
- E. Comini, *Anal. Chim. Acta*, 2006, **568**, 28–40.
- G. Korotcenkov, *Mater. Sci. Eng., B*, 2007, **139**, 1–23.
- S. Hu, H. Li, H. Liu, P. He and X. Wang, *Small*, 2015, **11**, 2624–2630.



- 13 J. X. Wang, X. W. Sun, Y. Yang, H. Huang, Y. C. Lee, O. K. Tan and L. Vayssieres, *Nanotechnology*, 2006, **17**, 4995–4998.
- 14 C. S. Rout, M. Hegde, A. Govindaraj and C. N. R. Rao, *Nanotechnology*, 2007, **18**, 205504.
- 15 C. Wang, X. Li, Y. Yuan, B. Wang, J. Huang, F. Xia, H. Zhang and J. Xiao, *Sens. Actuators, B*, 2017, **241**, 268–275.
- 16 T. Meek, M. Hu and M. J. Haire, *Semiconductive Properties of Uranium Oxides*, 2018.
- 17 P.-F. Sui, Z.-H. Dai, X.-L. Zhang and Y.-C. Zhao, *Chin. Phys. Lett.*, 2015, **32**, 077101.
- 18 H. He, D. A. Andersson, D. D. Allred and K. D. Rector, *J. Phys. Chem. C*, 2013, **117**, 16540–16551.
- 19 S. H. Taylor, *Heterogeneous Catalysis by Uranium Oxides*, Wiley-VCH Verlag GmbH & Co. KGaA, 2009.
- 20 D. Hudry, C. Apostolidis, O. Walter, T. Gouder, E. Courtois, C. Kubel and D. Meyer, *Chem.–Eur. J.*, 2013, **19**, 5297–5305.
- 21 H. Wu, O. Chen, J. Zhuang, J. Lynch, D. LaMontagne, Y. Nagaoka and Y. C. Cao, *J. Am. Chem. Soc.*, 2011, **133**, 14327–14337.
- 22 H. Wu, A. Yongan Yang and Y. C. Cao, *J. Am. Chem. Soc.*, 2006, **128**, 16522–16523.
- 23 D. Hudry, J.-C. Griveau, C. Apostolidis, O. Walter, E. Colineau, G. Rasmussen, D. Wang, V. S. K. Chakravadhala, E. Courtois, C. Kübel and D. Meyer, *Nano Res.*, 2013, **7**, 119–131.
- 24 L. Wang, R. Zhao, C. Z. Wang, L. Y. Yuan, Z. J. Gu, C. L. Xiao, S. A. Wang, X. W. Wang, Y. L. Zhao, Z. F. Chai and W. Q. Shi, *Chem.–Eur. J.*, 2014, **20**, 12655–12662.
- 25 M. Pradhan, S. Sarkar, A. K. Sinha, M. Basu and T. Pal, *CrystEngComm*, 2011, **13**, 2878.
- 26 R. Zhao, L. Wang, Z.-J. Gu, L.-Y. Yuan, C.-L. Xiao, Y.-L. Zhao, Z.-F. Chai and W.-Q. Shi, *CrystEngComm*, 2014, **16**, 2645.
- 27 D. D. Sood, *J. Sol-Gel Sci. Technol.*, 2010, **59**, 404–416.
- 28 M. Brykala, A. Deptula, M. Rogowski, W. Lada, T. Olczak, D. Wawszczak, T. Smolinski, P. Wojtowicz and G. Modolo, *J. Radioanal. Nucl. Chem.*, 2013, **299**, 651–655.
- 29 M. Martinez-Calvo, O. Kotova, M. E. Mobius, A. P. Bell, T. McCabe, J. J. Boland and T. Gunnlaugsson, *J. Am. Chem. Soc.*, 2015, **137**, 1983–1992.
- 30 T. Klawonn, A. Gansäuer, I. Winkler, T. Lauterbach, D. Franke, R. J. M. Nolte, M. C. Feiters, H. Börner, J. Hentschel and K. H. Dötz, *Chem. Commun.*, 2007, 1894–1895.
- 31 J. Liu, P. He, J. Yan, X. Fang, J. Peng, K. Liu and Y. Fang, *Adv. Mater.*, 2008, **20**, 2508–2511.
- 32 A. M. Amacher, J. Puigmartí-Luis, Y. Geng, V. Lebedev, V. Laukhin, K. Krämer, J. Hauser, D. B. Amabilino, S. Decurtins and S.-X. Liu, *Chem. Commun.*, 2015, **51**, 15063–15066.
- 33 G. Meinrath, *J. Alloys Compd.*, 1998, **275**, 777–781.
- 34 G. Meinrath, *J. Radioanal. Nucl. Chem.*, 1997, **224**, 119–126.
- 35 S. Tsushima, A. Rossberg, A. Ikeda, K. Müller and A. C. Scheinost, *Inorg. Chem.*, 2007, **46**, 10819–10826.
- 36 P. Zanonato, P. Di Bernardo, A. Bismondo, G. Liu, X. Chen and L. Rao, *J. Am. Chem. Soc.*, 2004, **126**, 5515–5522.
- 37 T. Loiseau, I. Mihalcea, N. Henry and C. Volkringer, *Coord. Chem. Rev.*, 2014, **266–267**, 69–109.
- 38 R. Bes, M. Rivenet, P. L. Solari, K. O. Kvashnina, A. C. Scheinost and P. M. Martin, *Inorg. Chem.*, 2016, **55**, 4260–4270.
- 39 F. Farges, C. W. Ponader, G. Calas and G. E. Brown, *Geochim. Cosmochim. Acta*, 1992, **56**, 4205–4220.
- 40 E. Hudson, J. Rehr and J. Bucher, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 1995, **52**, 13815–13826.
- 41 T. A. Marshall, K. Morris, G. T. Law, F. R. Livens, J. F. W. Mosselmans, P. Bots and S. Shaw, *Environ. Sci. Technol.*, 2014, **48**, 3724–3731.
- 42 D. J. Jones, J. Roziere, G. C. Allen and P. A. Tempest, *J. Chem. Phys.*, 1986, **84**, 6075–6082.
- 43 H. A. Thompson, G. E. Brown and G. A. Parks, *Am. Mineral.*, 1997, **82**, 483–496.
- 44 C. N. Watanabe and M. H. Gehlen, *J. Photochem. Photobiol., A*, 2003, **156**, 65–68.
- 45 K. Vidya, V. Kamble, N. Gupta and P. Selvam, *J. Catal.*, 2007, **247**, 1–19.
- 46 H. D. Burrows, *J. Chem. Educ.*, 1978, **55**, 125.
- 47 A. L. Patterson, *Phys. Rev.*, 1939, **56**, 978–982.
- 48 J. Chastain, R. C. King and J. Moulder, *Handbook of X-ray photoelectron spectroscopy: a reference book of standard spectra for identification and interpretation of XPS data*, Physical Electronics Division, Perkin-Elmer Corporation, Eden Prairie, Minnesota, 1992.
- 49 B. Bott, J. G. Firth, A. Jones, *et al.*, Semi-conducting gas sensitive devices, *US Pat.*, 3,865,550[P], 1975-2-11.
- 50 S.-W. Choi, J. Y. Park and S. S. Kim, *Nanotechnology*, 2009, **20**, 465603.
- 51 A. Vomiero, S. Bianchi, E. Comini, G. Faglia, M. Ferroni and G. Sberveglieri, *Cryst. Growth Des.*, 2007, **7**, 2500–2504.
- 52 Z. Liu, M. Miyauchi, T. Yamazaki and Y. Shen, *Sens. Actuators, B*, 2009, **140**, 514–519.
- 53 A. Gurlo and R. Riedel, *Angew. Chem., Int. Ed.*, 2007, **46**, 3826–3848.
- 54 J. Bates, C. Hinman and T. Kawada, *J. Am. Ceram. Soc.*, 1967, **50**, 652–656.
- 55 C. Colmenares, *Prog. Solid State Chem.*, 1975, **9**, 139–239.
- 56 O. L. G. Alderman, C. J. Benmore, J. K. R. Weber, L. B. Skinner, A. J. Tamalonis, S. Sendelbach, A. Hebden and M. A. Williamson, *Appl. Phys. Lett.*, 2017, **110**, 081904.
- 57 I. I. Kapshukov, N. V. Lyalyushkin, L. V. Sudakov, A. S. Bezv and O. V. Skiba, *J. Radioanal. Nucl. Chem.*, 1990, **143**, 213–220.
- 58 G. Allen and N. Holmes, *Can. J. Appl. Spectrosc.*, 1993, **38**, 124–130.
- 59 A. W. Bott, *Curr. Sep.*, 1998, **17**, 87–92.
- 60 K. Gelderman, L. Lee and S. Donne, *J. Chem. Educ.*, 2007, **84**, 685–688.
- 61 T. Meek, M. Hu and M. J. Haire, *Presented in part at the Waste Management 2001 Symposium*, 2001.
- 62 M. Mashock, K. Yu, S. Cui, S. Mao, G. Lu and J. Chen, *ACS Appl. Mater. Interfaces*, 2012, **4**, 4192–4199.
- 63 H. S. Woo, C. W. Na, I. D. Kim and J. H. Lee, *Nanotechnology*, 2012, **23**, 245501.

